


<b>Search Notes</b>  	<b>Application/Control No.</b>  10520075	<b>Applicant(s)/Patent Under Reexamination</b>  BOWEN ET AL.
	<b>Examiner</b>  Luu, Thanh X	<b>Art Unit</b>  2878

SEARCHED			
Class	Subclass	Date	Examiner
250	216	10/3/2006	/TXL/
385	52-56	10/3/2006	/TXL/
438	31	10/3/2006	/TXL/
	above to date	8/8/2008	/TXL/

SEARCH NOTES			
Search Notes		Date	Examiner
see EAST text search notes		10/3/2006	TXL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
250	216	8/8/2008	/TXL/
385	52-56	8/8/2008	/TXL/

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